Description: Test setup

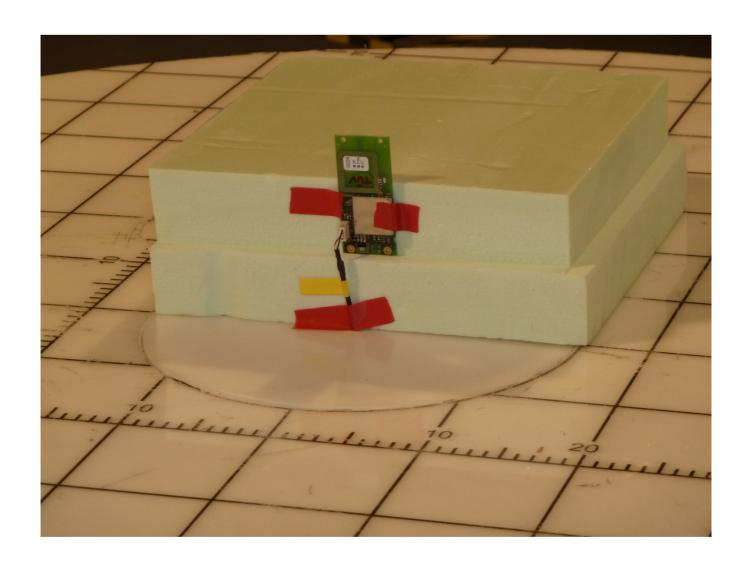
**Division:** Industry & Energy

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Description: Test setup 9 kHz - 30 MHz

**Division:** Industry & Energy

Department: FG

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Description: Test setup 30 - 1000 MHz

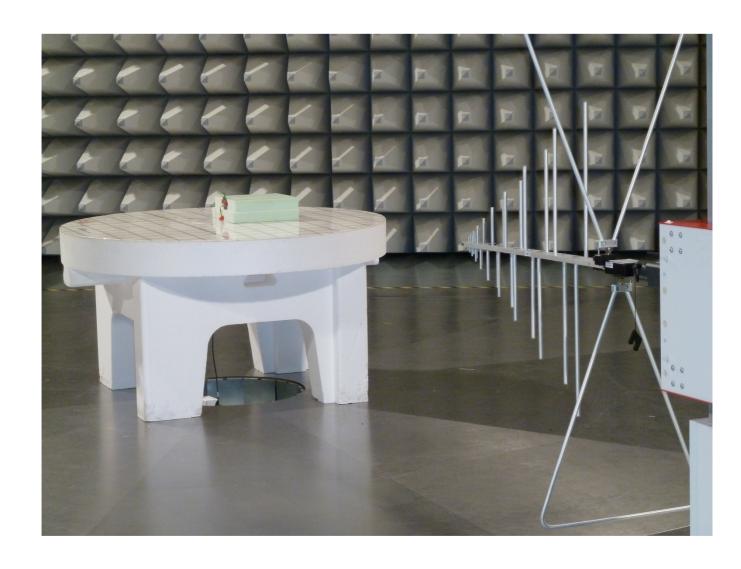
**Division:** Industry & Energy

Department: FG

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Description: Test setup 1 – 18 GHz

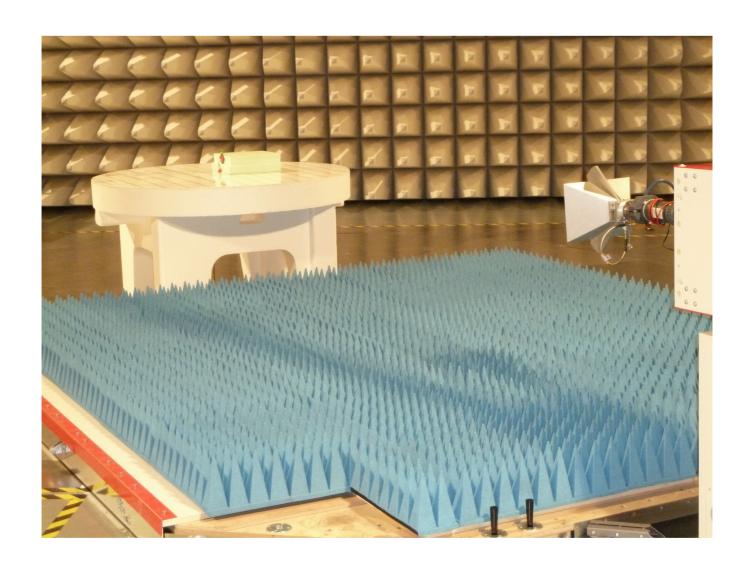
**Division:** Industry & Energy

Department: FG

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Description: Test setup detail - USB shield grounded

**Division:** Industry & Energy

Department: FG

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